



U74LVC1G00

CMOS IC

SINGLE 2-INPUT NAND GATE

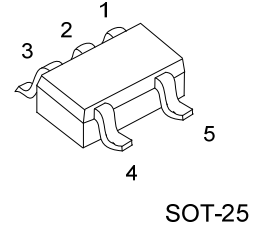
DESCRIPTION

The **U74LVC1G00** is a 2-input NAND gate device which provides the Function $Y=A \bullet B$ or $Y=\overline{A+B}$ in positive logic.

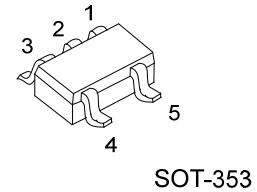
This device has power-down protective circuit preventing device from destruction when it is powered down.

FEATURES

- * Operate From 1.65V to 5.5V
- * Inputs Accept Voltages To 5.5V
- * High Noise Immunity
- * Low Power Dissipation
- * Max t_{PD} of 3.8 ns at 3.3V



SOT-25



SOT-353

ORDERING INFORMATION

Ordering Number		Package	Packing
Lead Free	Halogen Free		
U74LVC1G00L-AF5-R	U74LVC1G00G-AF5-R	SOT-25	Tape Reel
U74LVC1G00L-AL5-R	U74LVC1G00G-AL5-R	SOT-353	Tape Reel

U74LVC1G00L-AL5-R

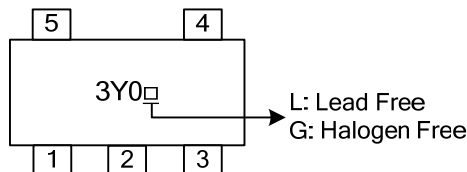
- (1) Packing Type
- (2) Package Type
- (3) Lead Free

(1) R: Tape Reel

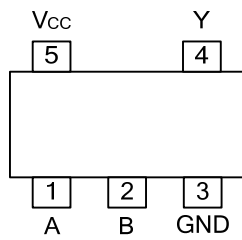
(2) AF5: SOT-25, AL5: SOT-353

(3) G: Halogen Free, L: Lead Free

MARKING



■ PIN CONFIGURATION

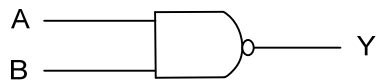


■ FUNCTION TABLE

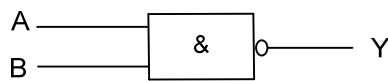
INPUT(A)	INPUT(B)	OUTPUT(Y)
H	H	L
H	L	H
L	H	H
L	L	H

Note: H: HIGH voltage level; L: LOW voltage level.

■ LOGIC DIAGRAM (positive logic)



Logic symbol



IEC logic symbol

■ ABSOLUTE MAXIMUM RATING (unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Supply Voltage		V_{CC}	-0.5 ~ +6.5	V
Input Voltage		V_{IN}	-0.5 ~ +6.5	V
Output Voltage	Output in the high or low state	V_{OUT}	-0.5 ~ +0.5	V
	Output in the high-impedance or power-off state		-0.5 ~ +6.5	V
V_{CC} or GND Current (Output in the power-off state)		I_{CC}	±100	mA
Continuous Output Current ($V_{OUT}=0$ to V_{CC})		I_{OUT}	±50	mA
Input Clamp Current ($V_{IN}<0$)		I_{IK}	-50	mA
Output Clamp Current ($V_{OUT}<0$)		I_{OK}	-50	mA
Storage Temperature Range		T_{STG}	-65 ~ +150	°C

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT
Junction to Ambient	SOT-25	θ_{JA}	230	°C/W
	SOT-353		350	

■ RECOMMENDED OPERATING CONDITIONS

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Supply Voltage	V_{CC}	Operating	1.65		5.5	V
		Data retention only	1.5			V
Input Voltage	V_{IN}		0		5.5	V
Output Voltage	V_{OUT}	High or low state	0		V_{CC}	V
High-level Output Current	I_{OH}	$V_{CC}=1.65V$			-4	mA
		$V_{CC}=2.3V$			-8	mA
		$V_{CC}=3V$			-16	mA
		$V_{CC}=3V$			-24	mA
		$V_{CC}=4.5V$			-32	mA
Low-level Output Current	I_{OL}	$V_{CC}=1.65V$			4	mA
		$V_{CC}=2.3V$			8	mA
		$V_{CC}=3V$			16	mA
		$V_{CC}=3V$			24	mA
		$V_{CC}=4.5V$			32	mA
Operating Temperature	T_A		-40		85	°C
Input Transition Rise or Fall Rate	t_R / t_F	$V_{CC}=1.8V\pm0.15V, 2.5V\pm0.2V$			20	ns/V
		$V_{CC}=3.3V\pm0.3V$			10	ns/V
		$V_{CC}=5V\pm0.5V$			5	ns/V

■ ELECTRICAL CHARACTERISTICS (T_A = 25°C, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
High-Level Input Voltage	V _{IH}	V _{CC} =1.65V ~ 1.95V	0.65*V _{CC}			V
		V _{CC} =2.3V ~ 2.7V	1.7			V
		V _{CC} =3V ~ 3.6V	2			V
		V _{CC} =4.5V ~ 5.5V	0.7*V _{CC}			V
Low-Level Input Voltage	V _{IL}	V _{CC} =1.65V ~ 1.95V			0.35*V _{CC}	V
		V _{CC} =2.3V ~ 2.7V			0.7	V
		V _{CC} =3V ~ 3.6V			0.8	V
		V _{CC} =4.5V ~ 5.5V			0.3*V _{CC}	V
High-Level Output Voltage	V _{OH}	I _{OH} =-100μA, V _{CC} =1.65 ~ 5.5V	V _{CC} -0.1			V
		I _{OH} =-4mA, V _{CC} =1.65V	1.2			V
		I _{OH} =-8mA, V _{CC} =2.3V	1.9			V
		I _{OH} =-16mA, V _{CC} =3.0V	2.4			V
		I _{OH} =-24mA, V _{CC} =3.0V	2.3			V
		I _{OH} =-32mA, V _{CC} =4.5V	3.8			V
Low-Level Output Voltage	V _{OL}	I _{OL} =100μA, V _{CC} =1.65 ~ 5.5V			0.1	V
		I _{OL} =4mA, V _{CC} =1.65V			0.45	V
		I _{OL} =8mA, V _{CC} =2.3V			0.3	V
		I _{OL} =16mA, V _{CC} =3.0V			0.4	V
		I _{OL} =24mA, V _{CC} =3.0V			0.55	V
		I _{OL} =32mA, V _{CC} =4.5V			0.55	V
Input Leakage Current	I _{I(LEAK)}	V _{IN} =5.5V or GND, V _{CC} =0 ~ 5.5V			±5	μA
Power OFF Leakage Current	I _{OFF}	V _{IN} or V _{OUT} =5.5V, V _{CC} =0V			±10	μA
Quiescent Supply Current	I _Q	V _{IN} =V _{CC} or GND, I _{OUT} =0, V _{CC} =1.65~5.5V			10	μA
Additional Quiescent Supply Current Per Input Pin	ΔI _Q	V _{CC} =3 ~ 5.5V, One input at V _{CC} -0.6V, Other inputs at V _{CC} or GND			500	μA
Input Capacitance	C _I	V _{CC} =3.3V, V _{IN} =V _{CC} or GND		4		pF

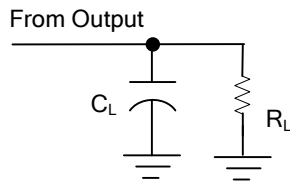
■ SWITCHING CHARACTERISTICS (T_A=25°C)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Propagation delay from input (A or B) to output(Y)	t _{PLH} / t _{PHL}	V _{CC} =1.8±0.15V	2.2		7.2	ns
		V _{CC} =2.5±0.2V	0.9		4.4	ns
		V _{CC} =3.3±0.3V	0.8		3.8	ns
		V _{CC} =5±0.5V	0.8		3.4	ns
		V _{CC} =1.8±0.15V, R _L =1KΩ	3.1		9	ns
		V _{CC} =2.5±0.2V, R _L =500Ω	1.3		5.5	ns
		V _{CC} =3.3±0.3V, R _L =500Ω	1		4.7	ns
		V _{CC} =5±0.5V, R _L =500Ω	1		4	ns

■ OPERATING CHARACTERISTICS (T_A=25°C)

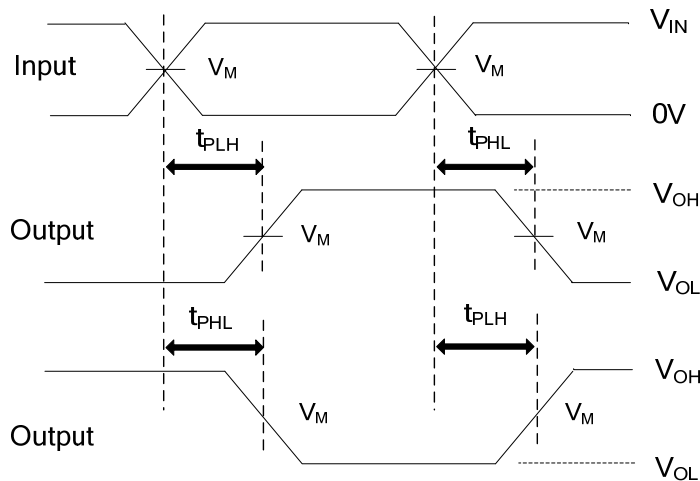
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Power Dissipation Capacitance	C _{PD}	V _{CC} =1.8V		22		pF
		V _{CC} =2.5V		22		
		V _{CC} =3.3V		23		
		V _{CC} =5.0V		25		

■ TEST CIRCUIT AND WAVEFORMS



TEST CIRCUIT

V_{CC}	Inputs		V_M	C_L	R_L
	V_{IN}	t_R, t_F			
$1.8V \pm 0.15V$	V_{CC}	$\leq 2ns$	$V_{CC}/2$	15pF	1M Ω
$2.5V \pm 0.2V$	V_{CC}	$\leq 2ns$	$V_{CC}/2$	15pF	1M Ω
$3.3V \pm 0.3V$	3V	$\leq 2.5ns$	1.5V	15pF	1M Ω
$5V \pm 0.5V$	V_{CC}	$\leq 2.5ns$	$V_{CC}/2$	15pF	1M Ω

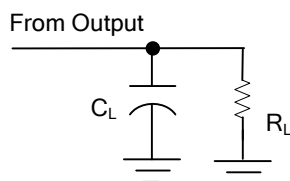


PROPAGATION DELAY TIMES

Note: C_L includes probe and jig capacitance.

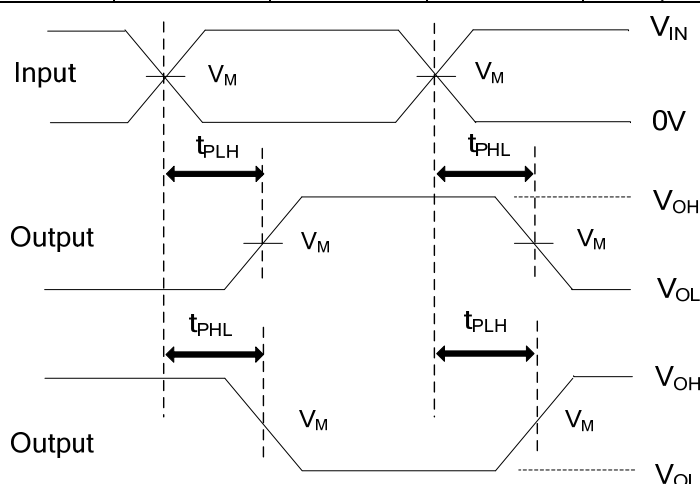
All input pulses are supplied by generators having the following characteristics: $P_{RR} \leq 10MHz$, $Z_O = 50\Omega$.

■ TEST CIRCUIT AND WAVEFORMS(Cont.)



TEST CIRCUIT

V_{CC}	Inputs		V_M	C_L	R_L
	V_{IN}	t_R, t_F			
$1.8V \pm 0.15V$	V_{CC}	$\leq 2ns$	$V_{CC}/2$	30pF	1K Ω
$2.5V \pm 0.2V$	V_{CC}	$\leq 2ns$	$V_{CC}/2$	30pF	500 Ω
$3.3V \pm 0.3V$	3V	$\leq 2.5ns$	1.5V	50pF	500 Ω
$5V \pm 0.5V$	V_{CC}	$\leq 2.5ns$	$V_{CC}/2$	50pF	500 Ω



PROPAGATION DELAY TIMES

Note: C_L includes probe and jig capacitance.

All input pulses are supplied by generators having the following characteristics: $P_{RR} \leq 10MHz$, $Z_O = 50\Omega$.

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